

### Vienna Rectifier MOSFET Power Module

#### Application

• Power supply

#### Features

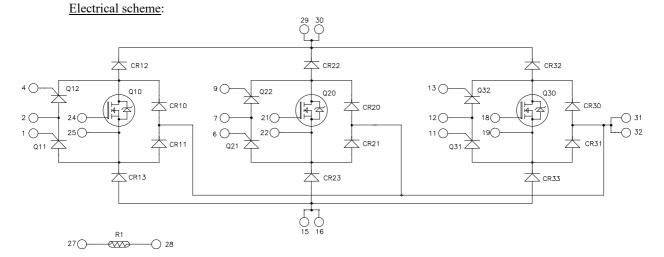
- Super junction MOSFET
  - Ultra low R<sub>DSon</sub>
  - Low Miller capacitance
  - Ultra low gate charge
  - Avalanche energy rated
  - Very rugged
- SiC Schottky diode
- Zero reverse recovery
- Zero forward recovery
- Temp. Independent switching behavior
- Positive temperature coefficient on VF

### Super junction MOSFET: V<sub>DSS</sub> = 600V ; R<sub>DSon</sub> = 99mΩ Max @ Tj = 25°C I<sub>D</sub> = 28A @ Tc = 25°C

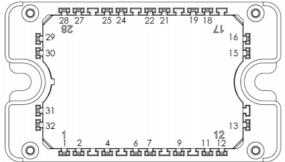
- AlN substrate for improved thermal performance
- Internal thermistor for temperature monitoring
- Kelvin emitter for easy drive
- Very low stray inductance
- High level of integration

#### Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- RoHS Compliant



#### Pin out Location:



CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

### All ratings (a) $T_i = 25^{\circ}C$ unless otherwise specified

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1. Absolute maximum ratings

**Thyristor** (per thyristor) Absolute maximum ratings

Symbol	Parameter			Max ratings	Unit
V <sub>DRM</sub>	Repetitive Peak Reverse Voltage			1200	V
I <sub>DRM</sub>	Repetitive Peak Reverse Current			1	mA
I <sub>TRMS</sub>	RMS on – state current		$T_J = 80^{\circ}C$	40	Α
I <sub>TSM</sub>	Surge on – state current	t = 10ms	$T_C = 45^{\circ}C$	300	Α
V <sub>RGM</sub>	Peak Reverse Gate Voltage			10	V
PD	Power Dissipation		$T_C = 25^{\circ}C$	186	W

### Super junction MOSFET (per MOSFET) Absolute maximum ratings

Symbol	Parameter	-	Max ratings	Unit
V <sub>DSS</sub>	Drain - Source Breakdown Voltage		600	V
T	Continuous Durin Current	$T_c = 25^{\circ}C$	28	
ID	Continuous Drain Current $T_c =$		22	А
I <sub>DM</sub>	Pulsed Drain current	75		
V <sub>GS</sub>	Gate - Source Voltage	±20	V	
R <sub>DSon</sub>	Drain - Source ON Resistance	99	mΩ	
PD	Maximum Power Dissipation	$T_c = 25^{\circ}C$	155	W
I <sub>AR</sub>	Avalanche current (repetitive and non repetitive)	11	А	
E <sub>AR</sub>	Repetitive Avalanche Energy		1.2	In I
E <sub>AS</sub>	Single Pulse Avalanche Energy	800	mJ	

#### SiC Diode (CR12/13, CR22/23, CR32/33) (per diode) Absolute maximum ratings

Symbol	Parameter		Max ratings	Unit
VR	DC reverse Voltage		(00	N/
V <sub>RRM</sub>	Peak Repetitive Reverse Voltage	600	v	
$I_{\rm F}$	DC Forward Current	$T_C = 125^{\circ}C$	10	А
I <sub>FRM</sub>	Repetitive Peak Forward Current	tp = 10ms	50	A
PD	Power Dissipation	$T_C = 25^{\circ}C$	68	W

#### FRED diode (CR10/11, CR20/21, CR30/31) (per diode) Absolute maximum ratings

Symbol	Parameter		Max ratings	Unit
V <sub>R</sub>	DC reverse Voltage	600	V	
V <sub>RRM</sub>	Peak Repetitive Reverse Voltage		600	v
$I_{\rm F}$	DC Forward Current	$T_{C} = 100^{\circ}C$	30	٨
I <sub>FRM</sub>	Repetitive Peak Forward Current	tp = 1ms	60	A
PD	Power Dissipation	$T_C = 25^{\circ}C$	107	W



### 2. Electrical Characteristics

Thyristor (per thyristor) Electrical Characteristics

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit	
VT	On – state Voltage	$I_T = 20A$	$T_J = 25^{\circ}C$		1.55		V
V <sub>TO</sub>	Direct On state threshold Voltage		$T_J = 125^{\circ}C$		0.90		v
r <sub>T</sub>	On – state Slope resistance				18		mΩ
V <sub>GT</sub>	Gate Trigger Voltage	$V_D = 6V$	$T_J = 25^{\circ}C$		1.5		V
I <sub>GT</sub>	Gate Trigger Current				130		mA
R <sub>thJC</sub>	Junction to Case Thermal Resistance					0.67	°C/W

### Super junction MOSFET (per MOSFET) Electrical Characteristics

·	<i>Characteristic</i>	Test Conditions	Min	Тур	Max	Unit
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{GS} = 0V$ ; $V_{DS} = 600V$			50	μΑ
R <sub>DS(on)</sub>	Drain – Source on Resistance	$V_{GS} = 10V, I_D = 18A$			99	mΩ
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 1.2 mA$	2.5	3	3.5	V
I <sub>GSS</sub>	Gate – Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			140	nA
Ciss	Input Capacitance	$V_{GS} = 0V$ ; $V_{DS} = 100V$		2800		пE
Coss	Output Capacitance	f = 1MHz		130		pF
Qg	Total gate Charge	$V_{GS} = 10V$		60		
$Q_{gs}$	Gate – Source Charge	$V_{Bus} = 400V$		14		nC
$Q_{gd}$	Gate – Drain Charge	$I_D = 18A$		20		
T <sub>d(on)</sub>	Turn-on Delay Time	$V_{GS} = 10V$		10		
$T_{\rm r}$	Rise Time	$V_{Bus} = 400V$ $I_D = 18A$		5		ns
T <sub>d(off)</sub>	Turn-off Delay Time			60		115
T <sub>f</sub>	Fall Time	$R_G = 3.3\Omega$		5		
R <sub>thJC</sub>	Junction to Case Thermal Resistanc	e			0.805	°C/W

### SiC Diode (CR12/13, CR22/23, CR32/33) (per SiC diode) Electrical Characteristics

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
I	Poverse Leekage Current	$V_{R} = 600 V$	$T_j = 25^{\circ}C$		10	60	
I <sub>RM</sub>	Reverse Leakage Current	$\mathbf{v}_{\mathrm{R}} = 000  \mathbf{v}$	$T_{j} = 175^{\circ}C$		20	300	μA
$V_{\rm F}$	Diode Forward Voltage	$I_F = 10A$	$T_j = 25^{\circ}C$		1.6	1.8	V
v F		$I_F = 10A$	$T_{j} = 175^{\circ}C$		2	2.4	v
Q <sub>C</sub>	Total Capacitive Charge	$I_F = 10A, V_R = 6$ di/dt = 500A/µs		28		nC	
С	Total Capacitance	$f = 1 MHz, V_R =$	$f = 1MHz, V_R = 200V$		65		pF
C		$f = 1 MHz, V_R =$	400V		50		pr
$R_{thJC}$	Junction to Case Thermal Resistance					2.2	°C/W



### FRED Diodes (CR10/11, CR20/21, CR30/31) (per diode) Electrical Characteristics

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
V <sub>RRM</sub>	Peak Repetitive Reverse Voltage			600			V
I <sub>RM</sub>	Reverse Leakage Current	$V_R = 600V$				50	μΑ
Υ.	Dia la Farma di Valta a	$I_F = 30A$	$T_j = 25^{\circ}C$		1.45		V
$V_{\rm F}$	Diode Forward Voltage	$V_{GE} = 0V$	$T_j = 125^{\circ}C$		1.35		V
+	Reverse Recovery Time		$T_j = 25^{\circ}C$		80		
t <sub>rr</sub>			$T_j = 125^{\circ}C$		105		ns
0	Reverse Recovery Charge	$I_{\rm F} = 30A$ $V_{\rm R} = 300V$	$T_j = 25^{\circ}C$		1.7		чС
Qn		$v_{\rm R} = 300 v_{\rm di/dt} = 3000 {\rm A}/{\mu {\rm s}}$	$T_j = 125^{\circ}C$		2.5		μC
Б	Devience Decessory Freemon		$T_j = 25^{\circ}C$		0.55		
$E_r$	Reverse Recovery Energy		$T_j = 125^{\circ}C$		0.8		mJ
$R_{thJC}$	Junction to Case Thermal Resistance					1.4	°C/W

### 3. Temperature sensor NTC

Symbol	Characteristic	Min	Тур	Max	Unit
R <sub>25</sub>	Resistance @ 25°C		22		kΩ
$\Delta R_{25}/R_{25}$	Resistance tolerance			5	%
$\Delta B/B$	Beta tolerance			3	70
B 25/100	$T_{25} = 298.16 \text{ K}$		3980		K

$$R_{T} = \frac{R_{25}}{\exp\left[B_{25/100}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]}$$
 T: Thermistor temperature  
R<sub>T</sub>: Thermistor value at T

### 4. package characteristics

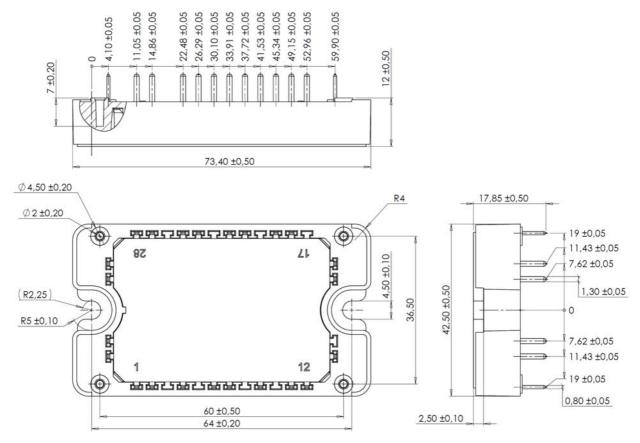
Symbol	Characteristic				Min	Max	Unit
V <sub>ISOL</sub>	RMS Isolation Voltage, any term	ninal to case	e t = 1 min, 50/60	)Hz	4000		V
	Q10, Q20, Q30, Q12, Q22, Q32			-40	150		
TJ	T <sub>J</sub> Operating junction temperature range		CR12/13, CR22/23, CR32/33 CR10/11, CR20/21, CR30/31		-40	175	°C
T <sub>JOP</sub>	Recommended junction temperature under switching conditions				-40	T <sub>J</sub> max -25	°C
T <sub>STG</sub>	Storage Temperature Range				-40	125	
T <sub>C</sub>	Operating Case Temperature	-40	125				
Torque	Mounting torque		To Heatsink	M4	2	3	N.m
Wt	Package Weight				110	g	

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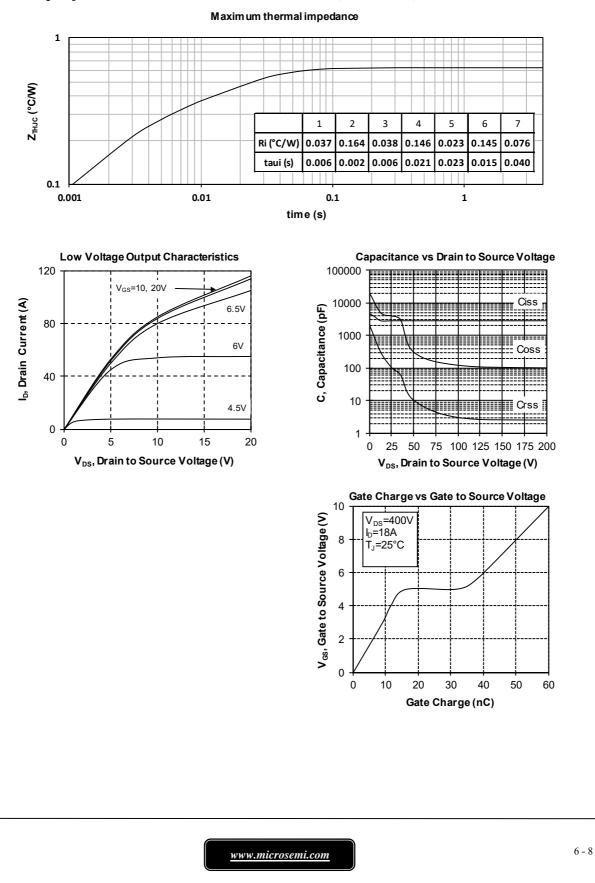
Package outline (dimensions in mm)



See application note 1906 - Mounting Instructions for SP3F Power Modules on www.microsemi.com



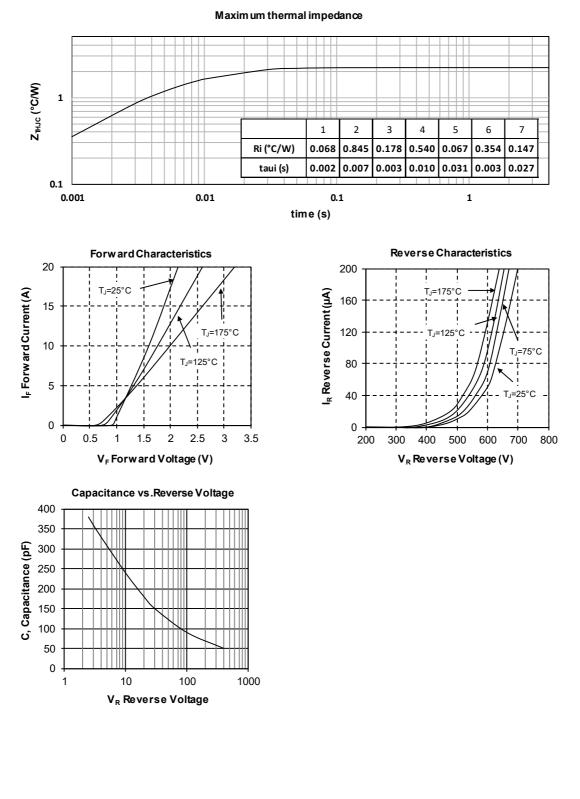
### Typical Super junction MOSFET Performance Curve (Per MOSFET)



MSCC60VRM99CT3AG - Rev 0 October, 2018



### Typical SiC diode Performance Curve (Per SiC diode)



MSCC60VRM99CT3AG - Rev 0 October, 2018



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